Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | BODNAR ET AL. | Examiner | Art Unit | Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,859,628 A	01-1999	Ross et al.	345/173
*	В	US-6,856,814 B2	02-2005	Kung et al.	455/557
*	С	US-5,974,334 A	10-1999	Jones, Jr., James H.	455/556.2
*	D	US-5,873,045 A	02-1999	Lee et al.	455/556.2
*	Е	US-5,854,984 A	12-1998	Buhrmann et al.	455/552.1
*	F	US-6,327,152 B1	12-2001	Saye, Tony Pingfu	361/732
*	G	US-6,418,309 B1	07-2002	Moon et al.	455/418
*	Н	US-6,434,403 B1	08-2002	Ausems et al.	455/556.2
*	- 1	US-6,516,202 B1	02-2003	Hawkins et al.	455/556.2
*	J	US-6,259,769 B1	07-2001	Page et al.	235/375
*	К	US-6,201,951 B1	03-2001	Duwaer et al.	455/74.1
*	L	US-6,215,992 B1	04-2001	Howell et al.	455/412.1
*	М	US-6,029,068 A	02-2000	Takahashi et al.	455/426.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
L	0					
	Р					
	Q					
	R					
	S					
	_					

NON-PATENT DOCUMENTS

_		TO THE POST OF THE
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	· u	
	V	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | 10/679,856 | BODNAR ET AL. | Examiner | Art Unit | Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,953,671 A	09-1999	Childress, Jeffrey S.	455/512
*	В	US-5,579,489 A	11-1996	Dornier et al.	710/303
*	C	US-5,737,394	04-1998	Anderson et al.	379/88.11
*	ם	US-5,422,656 A	06-1995	Allard et al.	345/173
*	E	US-5,606,594 A	02-1997	Register et al.	455/556.2
*	F	US-5,675,524	10-1997	Bernard, Marc Allen	708/109
*	G	US-5,832,388 A	11-1998	Williams et al.	455/557
*	Н	US-5,983,073 A	11-1999	Ditzik, Richard J.	455/11.1
*	_	US-5,606,594 A	02-1997	Register et al.	455/556.2
*	J	US-6,760,600 B2	07-2004	Nickum, Larry A.	455/557
*	К	US-6,140,937 A	10-2000	Wicks, James E.	340/7.1
*	L	US-6,674,358 B1	01-2004	Tinsley, Keith R.	340/7.63
*	М	US-6,941,158 B2	09-2005	ntwistle et al. 455/556.2	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/679,856 Examiner Pablo N. Tran Applicant(s)/Patent Under Reexamination BODNAR ET AL. Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,490,155 B2	12-2002	Han et al.	361/686
*	В	US-5,924,044 A	07-1999	Vannatta et al.	455/556.1
*	С	US-6,243,578 B1	06-2001	Koike, Kunihiko	455/557
*	D	US-6,657,654 B2	12-2003	Narayanaswami, Chandrasekhar	348/14.04
*	Е	US-5,898,774 A	04-1999	Shindo, Koji	379/433.13
*	F	US-5,802,460	09-1998	Parvulescu et al.	455/92
*	G	US-6,216,017 B1	04-2001	Lee et al.	455/567
*	Н	US-6,244,894 B1	06-2001	Miyashita, Toshikazu	439/500
*	1	US-6,188,917 B1	02-2001	Laureanti, Steven J.	455/573
*	J	US-6,952,617 B1	10-2005	Kumar, Rajendra	700/1
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
·	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.